RF Test Report

For

Applicant Name:	**Xwireless LLC**
Address:	11565 Old Georgetown Road, Rockville, MD, USA
EUT Name:	Mobile Phone
Brand Name:	Vortex
Model Number:	HD65Plus

Issued By

Company Name:	**BTF Testing Lab (Shenzhen) Co., Ltd.**
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Report Number:	BTF230713R00605
Test Standards:	47 CFR Part 15 Subpart E Section 15.407
FCC ID:	2ADLJ-HD65PLUS
Test Conclusion:	Pass
Test Date:	2023-07-13 to 2023-07-27
Date of Issue:	2023-07-31

Prepared By: Elma.Yang

Elma.Yang / Project Engineer

Date: 2023-07-31

Approved By: Ryan.CJ

Ryan.CJ / EMC Manager

Date: 2023-07-31

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Revision History		
Version	Issue Date	Revisions Content
R_V0	2023-07-31	Original
Note:	*Once the revision has been made, then previous versions reports are invalid.*	

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1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
FCC Registration Number:	518915
Designation Number:	CN1330

1.3 Laboratory Condition

Ambient Temperature:	20℃ to 25℃
Ambient Relative Humidity:	45% to 55%
Ambient Pressure:	100 kPa to 102 kPa

1.4 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.

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2. Product Information

2.1 Application Information

Company Name:	Xwireless LLC
Address:	11565 Old Georgetown Road, Rockville, MD, USA

2.2 Manufacturer Information

Company Name:	Xwireless LLC
Address:	11565 Old Georgetown Road, Rockville, MD, USA

2.3 Factory Information

Company Name:	ZTECH COMMNICATION(SZ) CO LTD
Address:	FL 7 BLOCK D BAO'AN ZHIGU INNOVATION PARK YIN'TIAN ROAD NO.4 XI'XIANG STR' BAO'AN DISTRICT SZ CHINA

2.4 General Description of Equipment under Test (EUT)

EUT Name	Mobile Phone
Under Test Model Name	HD65Plus

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2.5 Technical Information

The requirement for the following technical information of the EUT was tested in this report:

Modulation technology	OFDM
Modulation Type	BPSK, QPSK, 16QAM, 64QAM, 256QAM
Function	☐ Outdoor AP ☐ Indoor AP ☐ Fixed P2P ☒ Client
DFS type	☐ Master ☐ Slave with radar detection ☒ Slave without radar detection
Operation Frequency Range	U-NII Band 2A: 5.26~5.32 GHz
Frequency Block	U-NII Band 2A: 5.25~5.35 GHz
Channel Bandwidth	802.11a: 20 MHz 802.11n: 20 MHz, 40 MHz 802.11ac: 80MHz
Antenna Type	PIFA antenna
Antenna Gain	1.14 dBi(In test items related to antenna gain, the final results reflect this figure. This value is provided by the applicant.)
Antenna Impedance	50Ω
Antenna System (MIMO Smart Antenna)	N/A

Note:
#: The antenna gain provided by the applicant, and the laboratory will not be responsible for the accumulated calculation results which covers the information provided by the applicant.

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According to section 15.31(m), regards to the operating frequency range over 10 MHz, must select three channels which were tested. The Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, please see the below .

Band	Test Channel	20MHz		40MHz		80MHz	
		Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
U-NII-2A	CH_L	52	5260	54	5270	-	-
	CH_M	56	5280	-	-	58	5290
	CH_H	64	5320	62	5310	-	-

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3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 15 Subpart E Section 15.407	Unlicensed National Information Infrastructure Devices
2	ANSI C63.10-2013	American National Standard for Testing Unlicensed Wireless Devices
3	KDB905462 D02 v02	COMPLIANCE MEASUREMENT PROCEDURES FOR UNLICENSED-NATIONAL INFORMATION INFRASTRUCTURE DEVICES OPERATING IN THE 5250-5350 MHz AND 5470-5725 MHz BANDS INCORPORATING DYNAMIC FREQUENCY SELECTION
4	KDB905462 D03 v01r02	U-NII CLIENT DEVICES WITHOUT RADAR DETECTION CAPABILITY
5	KDB905462 D04 v01	OPERATIONAL MODES SUGGESTED FOR DFS TESTING

3.2 Summary of Test Result

No.	Description	FCC Part No.	Test Result	Test By	Verdict	Remark
1	Calibration of Radar Waveform	15.407(i)	ANNEX A.1	Elma yang	Pass	--
2	Channel Move Time, Channel Closing Transmission Time	15.407(i)	ANNEX A.2	Elma yang	Pass	--

3.3 Uncertainty of Test

The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2 and TR100 028-1/-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Occupied Channel Bandwidth	69 KHz
RF output power, conducted	0.87 dB
Power Spectral Density, conducted	0.69 dB
Unwanted Emissions, conducted	0.94 dB
All emissions, radiated(<1GHz)	4.12 dB
All emissions, radiated(>1GHz)	4.16 dB
Temperature	0.82 °C
Humidity	4.1 %

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4. Test Configuration

4.1 Environment Condition

Environment Parameter	Selected Values During Tests			
	Temperature	Voltage	Relative Humidity	Ambient Pressure
Normal Temperature, Normal Voltage (NTNV)	20°C to 25°C	DC 5V from Adapter	30% to 60%	100 kPa to 102 kPa

4.2 Test Equipment List

Conducted Method Test						
Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due	Use
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2022.11.24	2023.11.23	☒
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2022.11.24	2023.11.23	☒
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2022.11.24	2023.11.23	☒
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2022.11.24	2023.11.23	☒
RF Sensor Unit	Techy	TR1029-2	/	2022.11.24	2023.11.23	☒
RF Control Unit	Techy	TR1029-1	/	2022.11.24	2023.11.23	☒
RFTest software	/	V1.00	/	/	/	☒

4.3 Test Auxiliary Equipment

Description	Manufacturer	Model	FCC ID	Use
Wireless AC3100	ASUS	RT-AC88U	MSQ-RTGW00	☒
Notebook	Dell Inc.	Inspiron 13-5368	/	☒

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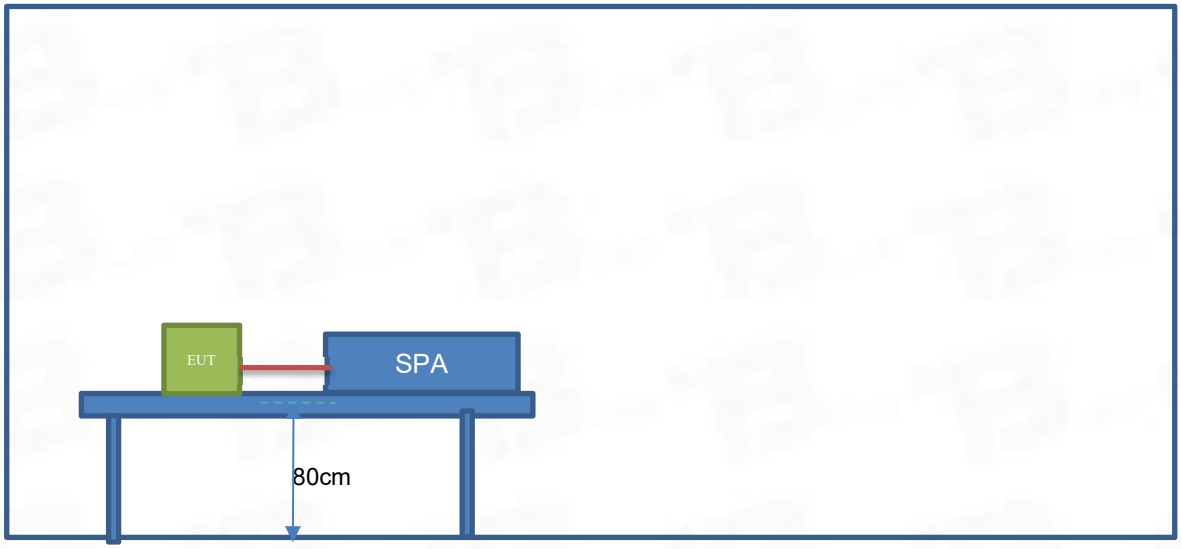
4.4 Test Setup

Test Setup 1



5. DFS TEST INFORMATION

5.1 DFS test requirement

The following table from FCC KDB905462 D02 UNII DFS Compliance procedures new rules list the applicable requirements for the DFS testing.

Table 1: Applicability of DFS Requirements Prior to Use of a Channel

Requirement	Operational Mode		
	Master	Client Without Radar Detection	Client With Radar Detection
Non-Occupancy Period	Yes	Not required	Yes
DFS Detection Threshold	Yes	Not required	Yes
Channel Availability Check Time	Yes	Not required	Not required
U-NII Detection Bandwidth	Yes	Not required	Yes

Table 2: Applicability of DFS requirements during normal operation

Requirement	Operational Mode	
	Master Device or Client with Radar Detection	Client Without Radar Detection
DFS Detection Threshold	Yes	Not required
Channel Closing Transmission Time	Yes	Yes
Channel Move Time	Yes	Yes
U-NII Detection Bandwidth	Yes	Not required

Additional requirements for devices with multiple bandwidth modes	Master Device or Client with Radar Detection	Client Without Radar Detection
U-NII Detection Bandwidth and Statistical Performance Check	All BW modes must be tested	Not required
Channel Move Time and Channel Closing Transmission Time	Test using widest BW mode available	Test using the widest BW mode available for the link
All other tests	Any single BW mode	Not required
Note: Frequencies selected for statistical performance check (Section 7.8.4) should include several frequencies within the radar detection bandwidth and frequencies near the edge of the radar detection bandwidth. For 802.11 devices it is suggested to select frequencies in each of the bonded 20 MHz channels and the channel center frequency.		

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Master Devices

a) The Master Device will use DFS in order to detect Radar Waveforms with received signal strength above the DFS Detection Threshold in the 5250~5350 MHz and 5470~5725 MHz bands. DFS is not required in the 5150~5250 MHz or 5725~5825 MHz bands.

b) Before initiating a network on a Channel, the Master Device will perform a Channel Availability Check for a specified time duration (Channel Availability Check Time) to ensure that there is no radar system operating on the Channel, using DFS described under subsection a) above.

c) The Master Device initiates a U-NII network by transmitting control signals that will enable other U-NII devices to Associate with the Master Device.

d) During normal operation, the Master Device will monitor the Channel (In-Service Monitoring) to ensure that there is no radar system operating on the Channel, using DFS described under a).

e) If the Master Device has detected a Radar Waveform during In-Service Monitoring as described under d), the Operating Channel of the U-NII network is no longer an Available Channel. The Master Device will instruct all associated Client Device(s) to stop transmitting on this Channel within the Channel Move Time. The transmissions during the Channel Move Time will be limited to the Channel Closing Transmission Time.

f) Once the Master Device has detected a Radar Waveform it will not utilize the Channel for the duration of the Non-Occupancy Period.

g) If the Master Device delegates the In-Service Monitoring to a Client Device, then the combination will be tested to the requirements described under d) through f) above.

h)

Client Devices

a) A Client Device will not transmit before having received appropriate control signals from a Master Device.

b) A Client Device will stop all its transmissions whenever instructed by a Master Device to which it is associated and will meet the Channel Move Time and Channel Closing Transmission Time requirements. The Client Device will not resume any transmissions until it has again received control signals from a Master Device.

c) If a Client Device is performing In-Service Monitoring and detects a Radar Waveform above the DFS Detection Threshold, it will inform the Master Device. This is equivalent to the Master Device detecting the Radar Waveform and d) through f) of section 5.1.1 apply.

d) Irrespective of Client Device or Master Device detection the Channel Move Time and Channel Closing Transmission Time requirements remain the same.

e) The client test frequency must be monitored to ensure no transmission of any type has occurred for 30 minutes. Note: If the client moves with the master, the device is considered compliant if nothing appears in the client non-occupancy period test. For devices that shut down (rather than moving channels), no beacons should appear.

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Table 4: DFS Response Requirement Values

Paramenter	Value
Non-occupancy period	Minimum 30 minutes
Channel Availability Check Time	60 seconds
Channel Move Time	10 seconds See Note 1.
Channel Closing Transmission Time	200 milliseconds + an aggregate of 60 milliseconds over remaining 10 second period. See Notes 1 and 2.
U-NII Detection Bandwidth	Minimum 100% of the U-NII 99% transmission power bandwidth. See Note 3.

Note 1: Channel Move Time and the Channel Closing Transmission Time should be performed with Radar Type 0. The measurement timing begins at the end of the Radar Type 0 burst.
Note 2: The Channel Closing Transmission Time is comprised of 200 milliseconds starting at the beginning of the Channel Move Time plus any additional intermittent control signals required facilitating a Channel move (an aggregate of 60 milliseconds) during the remainder of the 10 second period. The aggregate duration of control signals will not count quiet periods in between transmissions.
Note 3: During the U-NII Detection Bandwidth detection test, radar type 0 should be used. For each frequency step the minimum percentage of detection is 90 percent. Measurements are performed with no data traffic.

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5.2 DFS Detection Thresholds

Table 3: DFS Detection Thresholds for Master Devices and Client Devices With Radar Detection

Maximum Transmit Power	Value (See Notes 1, 2, and 3)
EIRP ≥ 200 milliwatt	-64 dBm
EIRP < 200 milliwatt and power spectral density < 10 dBm/MHz	-62 dBm
EIRP < 200 milliwatt that do not meet the power spectral density requirement	-64 dBm
Note 1: This is the level at the input of the receiver assuming a 0 dBi receive antenna. Note 2: Throughout these test procedures an additional 1 dB has been added to the amplitude of the test transmission waveforms to account for variations in measurement equipment. This will ensure that the test signal is at or above the detection threshold level to trigger a DFS response. Note3: EIRP is based on the highest antenna gain. For MIMO devices refer to KDB Publication 662911 D01.	

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5.3 Radar Test Waveforms

This section provides the parameters for required test waveforms, minimum percentage of successful detections, and the minimum number of trials that must be used for determining DFS conformance. Step intervals of 0.1 microsecond for Pulse Width, 1 microsecond for PRI, 1 MHz for chirp width and 1 for the number of pulses will be utilized for the random determination of specific test waveforms.

Table 5 Short Pulse Radar Test Waveforms

Radar Type	Pulse Width (μsec)	PRI (μsec)	Number of Pulses	Minimum Percentage of Successful Detection	Minimum Number of Trials
0	1	1428	18	See Note 1	See Note 1
1	1	Test A: 15 unique PRI values randomly selected from the list of 23 PRI values in Table 5a	$\text{Roundup}\left\{\left(\frac{1}{360}\right)\cdot\left(\frac{19\cdot 10^6}{\text{PRI}_{\mu sec}}\right)\right\}$	60%	30
		Test B: 15 unique PRI values randomly selected within the range of 518-3066 μsec, with a minimum increment of 1 μsec, excluding PRI values selected in Test A			
2	1-5	150-230	23-29	60%	30
3	6-10	200-500	16-18	60%	30
4	11-20	200-500	12-16	60%	30
Aggregate (Radar Types 1-4)				80%	120
Note 1: Short Pulse Radar Type 0 should be used for the detection bandwidth test, channel move time, and channel closing time tests.					

A minimum of 30 unique waveforms are required for each of the Short Pulse Radar Types 2 through 4. If more than 30 waveforms are used for Short Pulse Radar Types 2 through 4, then each additional waveform must also be unique and not repeated from the previous waveforms. If more than 30 waveforms are used for Short Pulse Radar Type 1, then each additional waveform is generated with Test B and must also be unique and not repeated from the previous waveforms in Tests A or B.

For example if in Short Pulse Radar Type 1 Test B a PRI of 3066 μsec is selected, the number of pulses would be Round up $\left\{\left(\frac{1}{360}\right)\cdot\left(\frac{19\cdot 10^6}{3066}\right)\right\}$ = Round up {17.2} = 18.

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Table 5a - Pulse Repetition Intervals Values for Test A

Pulse Repetition Frequency Number	Pulse Repetition Frequency (Pulses Per Second)	Pulse Repetition Interval (Microseconds)
1	1930.5	518
2	1858.7	538
3	1792.1	558
4	1730.1	578
5	1672.2	598
6	1618.1	618
7	1567.4	638
8	1519.8	658
9	1474.9	678
10	1432.7	698
11	1392.8	718
12	1355	738
13	1319.3	758
14	1285.3	778
15	1253.1	798
16	1222.5	818
17	1193.3	838
18	1165.6	858
19	1139	878
20	1113.6	898
21	1089.3	918
22	1066.1	938
23	326.2	3066

Table 6 – Long Pulse Radar Test Waveform

Radar Type	Pulse Width (μsec)	Chirp Width (MHz)	PRI (μsec)	Number of Pulses per Burst	Number of Bursts	Minimum Percentage of Successful Detection	Minimum Number of Trials
5	50-100	5-20	1000-2000	1-3	8-20	80%	30

The parameters for this waveforms are randomly chosen. Thirty unique waveforms are required for the Long Pulse Radar Type waveforms. If more than 30 waveforms are used for the Long Pulse Radar Type wave forms, then each additional waveform must also be unique and not repeated from the previous waveforms.

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Table 7 – Frequency Hopping Radar Test Waveform

Radar Type	Pulse Width (μsec)	PRI (μsec)	Pulses per Hop	Hopping Rate (kHz)	Hopping Sequence Length (msec)	Minimum Percentage of Successful Detection	Minimum Number of Trials
6	1	333	9	0.333	300	70%	30

For the Frequency Hopping Radar Type, the same Burst parameters are used for each wave form. The hopping sequence is different for each wave form and a 100-length segment is selected from the hopping sequence defined by the following algorithm:

The first frequency in a hopping sequence is selected randomly from the group of 475 integer frequencies from 5250–5724MHz.Next,the frequency that was just chosen is removed from the group and a frequency is randomly selected from the remaining 474 frequencies in the group. This process continues until all 475 frequencies are chosen for the set. For selection of a random frequency, the frequencies remaining within the group are always treated as equally likely.

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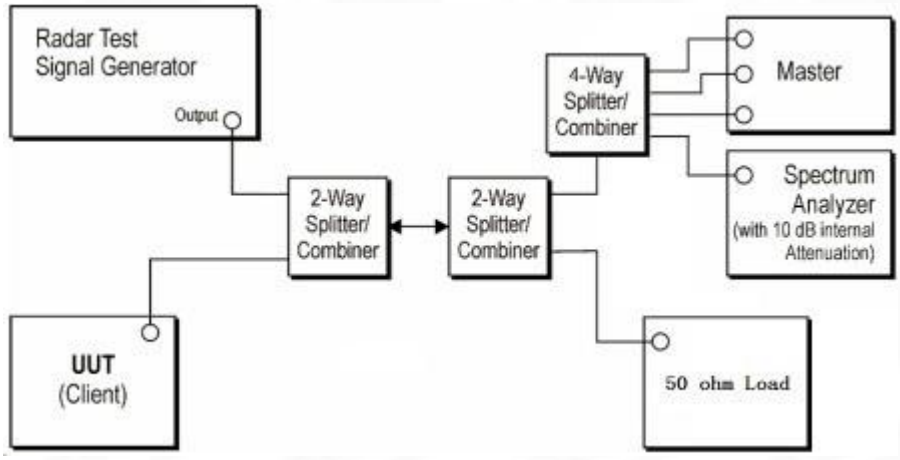
6. Test Item

6.1 Calibration of Radar Waveform

6.1.1 TEST CONFIGURATION



6.1.2 Test Procedure

a) A 50 ohm load is connected in place of the spectrum analyzer, and the spectrum analyzer is connected to place of the master

b) The interference Radar Detection Threshold Level is -62dBm + 0dBi +1dB = -61dBm that had been taken into account the output power range and antenna gain.

c) The following equipment setup was used to calibrate the conducted radar waveform. A vector signal generator was utilized to establish the test signal level for radar type 0. During this process there were no transmissions by either the master or client device. The spectrum analyzer was switched to the zero spans (time domain) at the frequency of the radar waveform generator. Peak detection was used. The spectrum analyzer resolution bandwidth (RBW) and video bandwidth (VBW) were set to 3MHz. The spectrum analyzer had offset -1.0dB to compensate RF cable loss 1.0dB.

d) The vector signal generator amplitude was set so that the power level measured at the spectrum analyzer was - -62dBm + 0dBi +1dB = -61dBm. Capture the spectrum analyzer plots on short pulse radar waveform.

6.1.3 Test Result

Please refer to ANNEX A.1

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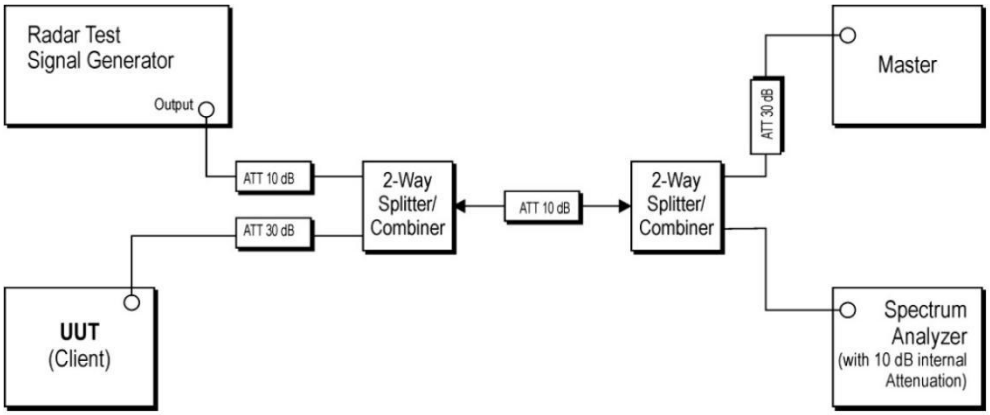
6.2 Channel Move Time, Channel Closing Transmission Time

6.2.1 TEST CONFIGURATION



6.2.2 Test Procedure

a) The radar pulse generator is setup to provide a pulse at frequency that the master and client are operating. A type 0 radar pulse with a 1us pulse width and a 1428us PRI is used for the testing.

b) The vector signal generator is adjusted to provide the radar burst (18 pulses) at the level of approximately -61dBm at the antenna port of the master device.

c) A trigger is provided from the pulse generator to the DFS monitoring system in order to capture the traffic and the occurrence of the radar pulse.

d) EUT will associate with the master at channel. The file “iperf.exe” specified by the FCC is streamed from the PC 2 through the master and the client device to the PC 1 and played in full motion video using Media Player Classic Ver. 6.4.8.6 in order to properly load the network for the entire period of the test.

e) When radar burst with a level equal to the DFS Detection Threshold +1dB is generated on the operating channel of the U-NII device. At time T0 the radar waveform generator sends a burst of pulse of the radar waveform at Detection Threshold +1dB.

f) Observe the transmissions of the EUT at the end of the radar Burst on the Operating Channel Measure and record the transmissions from the UUT during the observation time (Channel Move Time). One 15 seconds plot is reported for the Short Pulse Radar Type 0. The plot for the Short Pulse Radar Types start at the end of the radar burst. The Channel Move Time will be calculated based on the zoom in 600ms plot of the Short Pulse Radar Type

g) Measurement of the aggregate duration of the Channel Closed Transmission Time method. With the spectrum analyzer set to zero span tuned to the center frequency of the EUT operating channel at the radar simulated

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frequency, peak detection, and max hold, the dwell time per bin is given by: Dwell (0.3ms) =S (12000ms) / B (4000); where Dwell is the dwell time per spectrum analyzer sampling bin, S is sweep time and B is the number of spectrum analyzer sampling bins. An upper bound of the aggregate duration of the intermittent control signals of Channel Closing Transmission Time is calculated by: C (ms)= N X Dwell (0.3ms); where C is the Closing Time, N is the number of spectrum analyzer sampling bins (intermittent control signals) showing a U-NII transmission and Dwell is the dwell time per bin.

h) Measurement the EUT for more than 30 minutes following the channel move time to verify that no transmission or beacons occur on this channel.

6.2.3 Test Result

Please refer to ANNEX A.2

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ANNEX A Test Results

1. Signal Calibration

1.1 SC

1.1.1 Test Result

Band: 2A							
Mode	Bandwidth (MHz)	Frequency (MHz)	Radar Signal		Signal Calibration		Verdict
			Type	Trial Id	Result	Limit	
802.11a	20	5260	0	0	Refer To Test Graph		Pass
802.11n (HT20)	20	5260	0	0	Refer To Test Graph		Pass
802.11ac (VHT20)	20	5260	0	0	Refer To Test Graph		Pass

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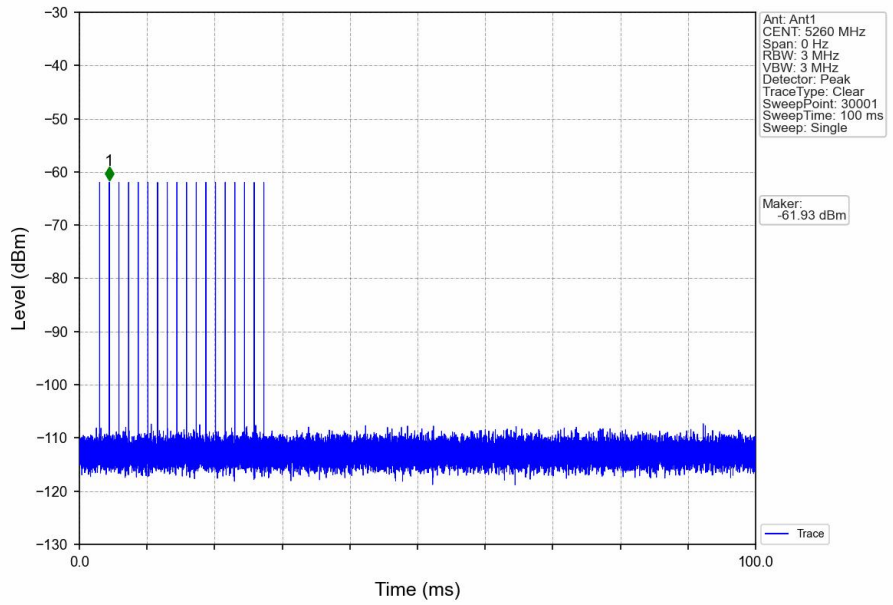
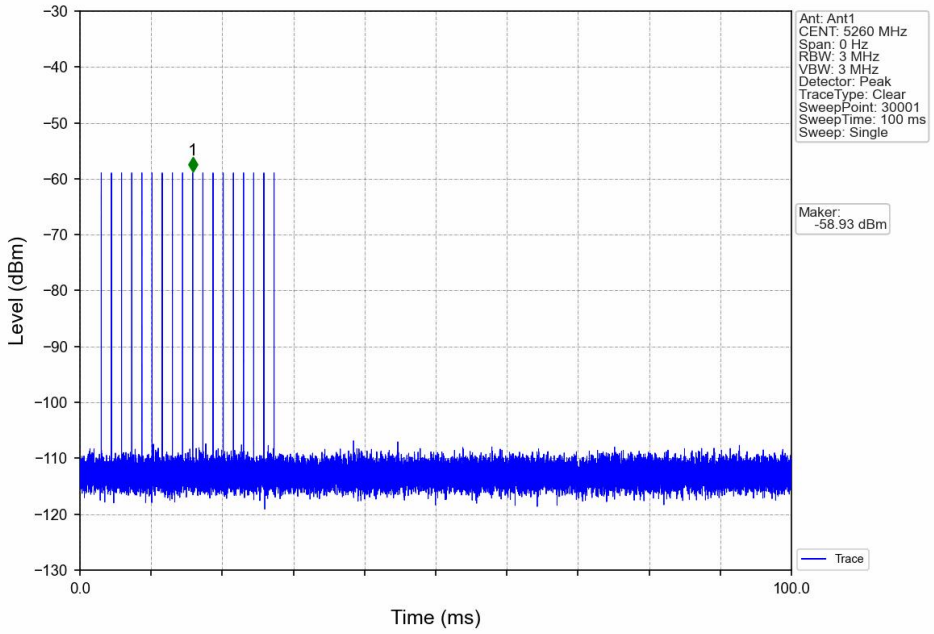
1.1.2 Test Graph

Signal Calibration_802.11a_2_5260MHz_RadarType0_Trial0



Signal Calibration_802.11n(HT20)_2_5260MHz_RadarType0_Trial0



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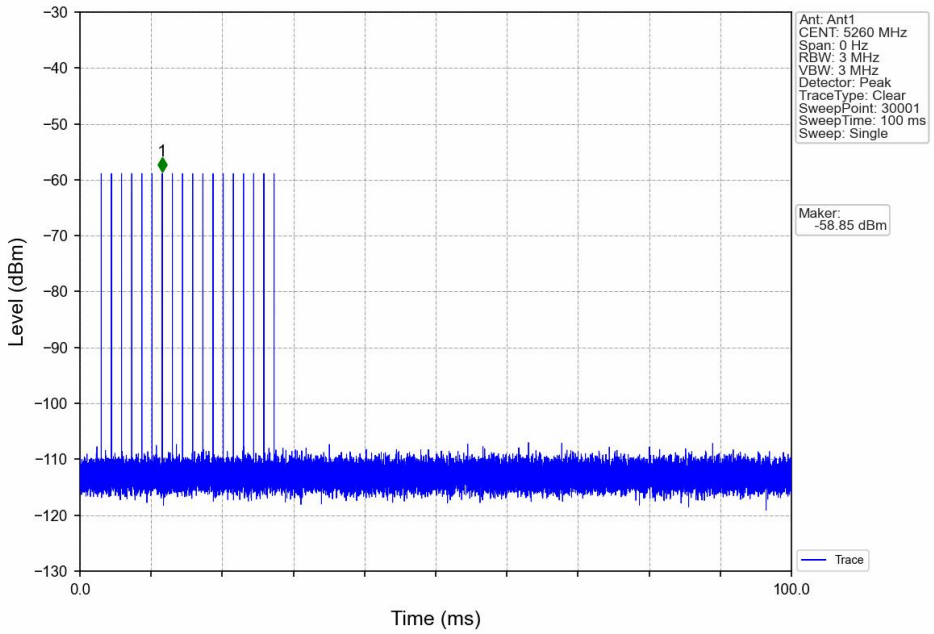
Signal Calibration_802.11ac(VHT20)_2_5260MHz_RadarType0_Trial0



2. Channel Loading (Payload)

2.1 Payload

2.1.1 Test Result

Band: 2					
Mode	Bandwidth (MHz)	Frequency (MHz)	Channel Loading (Payload) (%)		Verdict
			Result	Limit	
802.11a	20	5260	90.64	>=30	Pass
802.11n (HT20)	20	5260	93.12	>=30	Pass
802.11ac (VHT20)	20	5260	94.05	>=30	Pass

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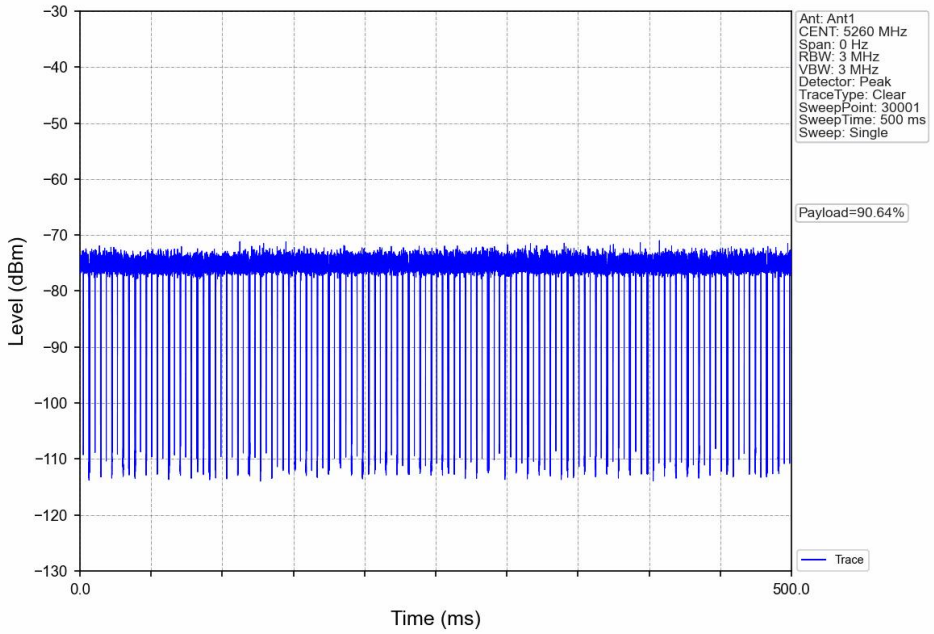
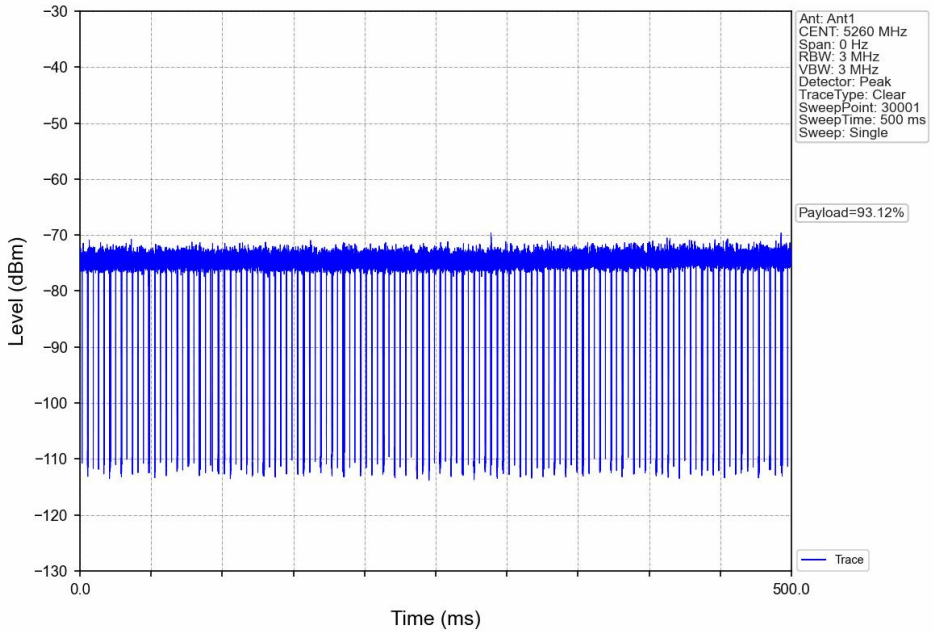
2.1.2 Test Graph

Channel Loading (Payload)_802.11a_2_5260MHz



Channel Loading (Payload)_802.11n(HT20)_2_5260MHz



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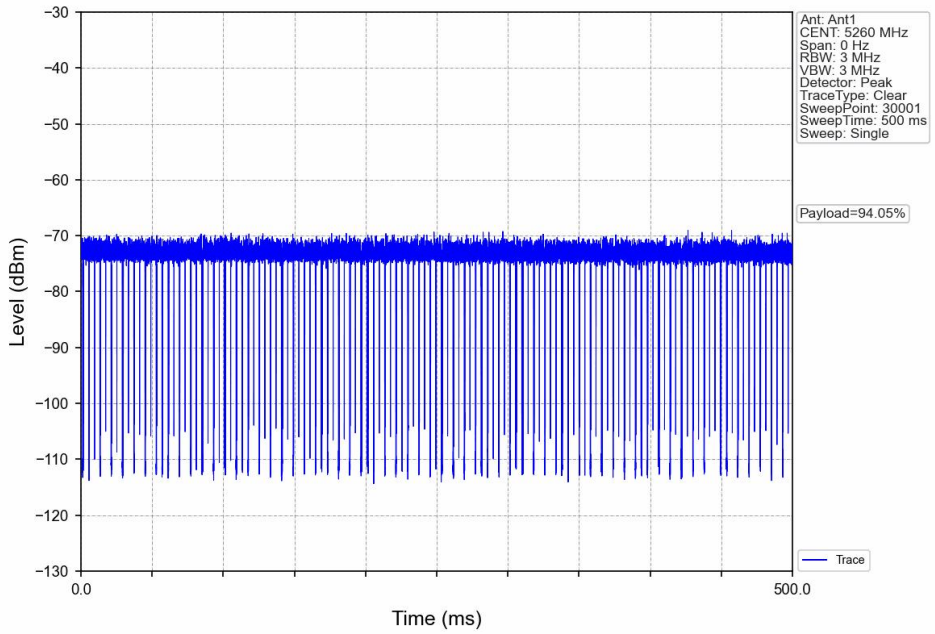
Channel Loading (Payload)_802.11ac(VHT20)_2_5260MHz



3. Channel Move Time and Closing Transmission Time

3.1 CMT_CTT

3.1.1 Test Result

Band: 2A					
Mode	Bandwidth (MHz)	Frequency (MHz)	Channel Move Time and Closing Transmission Time		Verdict
			Result	Limit	
802.11a	20	5260	Refer To Test Graph		Pass
802.11n (HT20)	20	5260	Refer To Test Graph		Pass
802.11ac (VHT20)	20	5260	Refer To Test Graph		Pass

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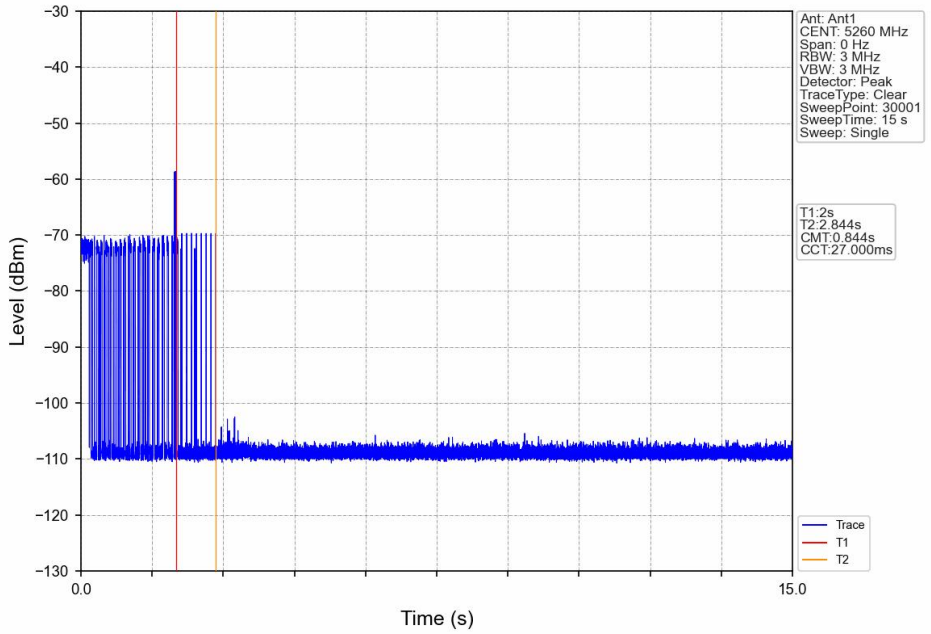
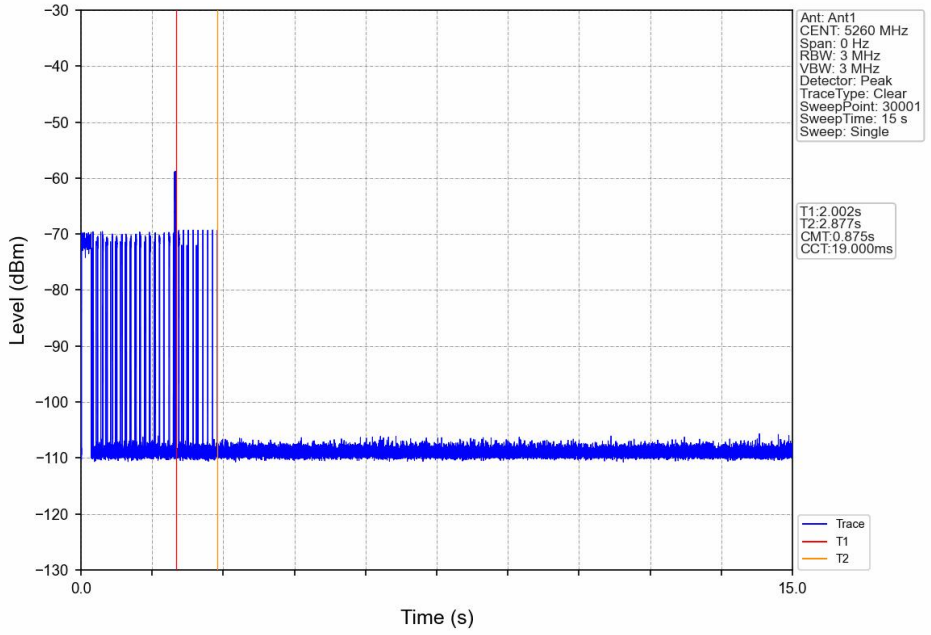
3.1.2 Test Graph

Channel Move Time and Closing Transmission Time_802.11a_2A_5260MHz



Channel Move Time and Closing Transmission Time_802.11n(HT20)_2_5260MHz



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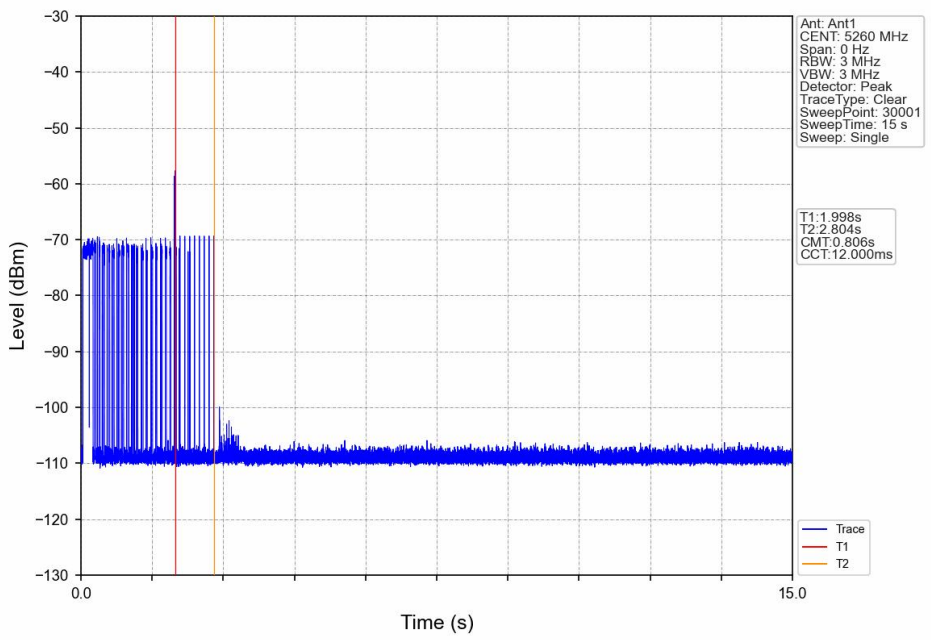
Channel Move Time and Closing Transmission Time_802.11ac(VHT20)_2_5260MHz



4. The time for slave and master complete its power-on cycle

The time for EUT to complete its power-on cycle is 0.80 S.

The time for AP to complete its power-on cycle is 171.9 S.

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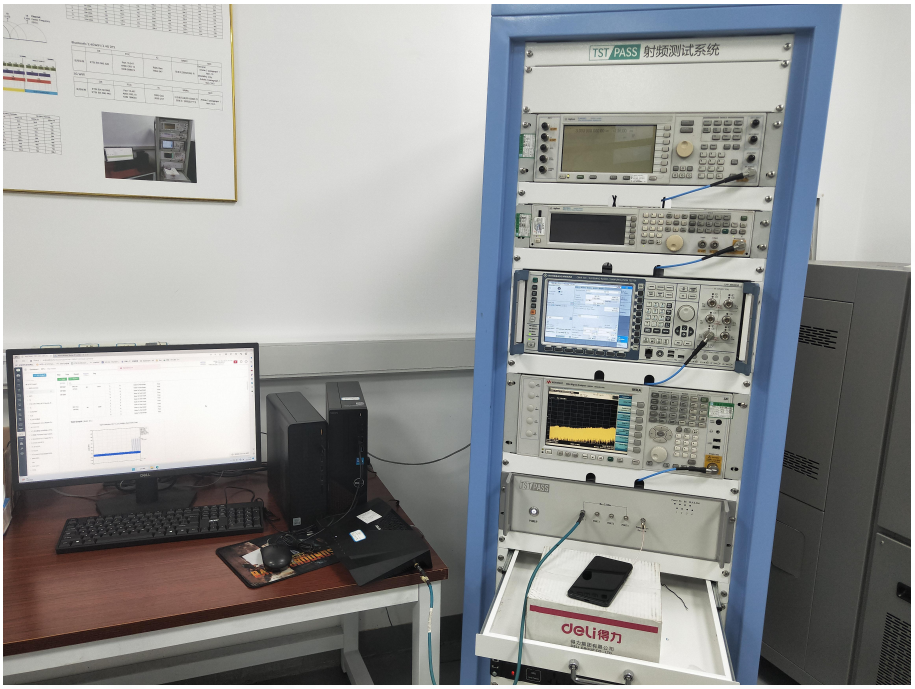
ANNEX B TEST SETUP PHOTOS



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ANNEX C EUT EXTERNAL PHOTOS

Please refer to Report BTF230713R00601

ANNEX D EUT INTERNAL PHOTOS

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